

SLLS918-JULY 2008

3.3-V / 5-V HIGH-SPEED DIGITAL ISOLATORS

FEATURES

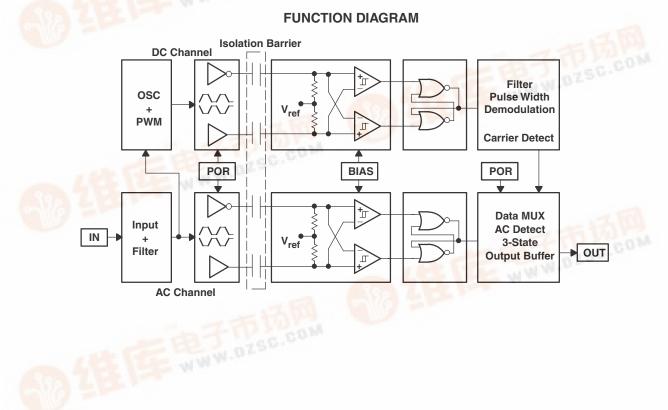
- **Qualified for Automotive Applications**
- 4000-V_(peak) Isolation
 - UL 1577, IEC 60747-5-2 (VDE 0884, Rev 2), IEC 61010-1
 - 50-kV/s Transient Immunity (Typ)
- Signaling Rate 0 Mbps to 150 Mbps
 - Low Propagation Delay
 - (Pulse-Width Distortion) Low Pulse Skew

- Low-Power Sleep Mode
- **High Electromagnetic Immunity**
- Low Input Current Requirement
- Failsafe Output
- **Drop-In Replacement for Most Optical and Magnetic Isolators**

DESCRIPTION

The ISO721 is a digital isolator with a logic input and output buffer separated by a silicon oxide (SiO₂) insulation barrier. This barrier provides galvanic isolation of up to 4000 V. Used in conjunction with isolated power supplies, this device prevents noise currents on a data bus or other circuits from entering the local ground, and interfering with or damaging sensitive circuitry.

A binary input signal is conditioned, translated to a balanced signal, then differentiated by the capacitive isolation barrier. Across the isolation barrier, a differential comparator receives the logic transition information, then sets or resets a flip-flop and the output circuit accordingly. A periodic update pulse is sent across the barrier to ensure the proper dc level of the output. If this dc refresh pulse is not received for more than 4 µs, the input is assumed to be unpowered or not being actively driven, and the failsafe circuit drives the output to a logic high state.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

A

df.dzsc.com

SI 查销 化 0 72% Q1 供应商

DESCRIPTION (CONTINUED)

The symmetry of the dielectric and capacitor within the integrated circuitry provides for close capacitive matching and allows fast transient voltage changes between the input and output grounds without corrupting the output. The small capacitance and resulting time constant provide for fast operation with signaling rates⁽¹⁾ from 0 Mbps (dc) to 100 Mbps.

The device requires two supply voltages of 3.3 V, 5 V, or any combination. All inputs are 5-V tolerant when supplied from a 3.3-V supply, and all outputs are 4-mA CMOS. The device has a TTL input threshold and a noise-filter at the input that prevents transient pulses of up to 2 ns in duration from being passed to the output of the device.

The ISO721 is characterized for operation over the ambient temperature range of -40°C to 125°C.

(1) The signaling rate of a line is the number of voltage transitions that are made per second expressed in the units bps (bits per second).

D PACKAGE (TOP VIEW) V_{CC1} 1 8 V_{CC2} IN 2 7 GND2 V_{CC1} 3 9 6 OUT GND1 4 5 GND2

ORDERING INFORMATION⁽¹⁾

T _A	PACK	AGE ⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 125°C	SOIC – D	Reel of 2500	ISO721QDRQ1	IS721Q

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

(2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

REGULATORY INFORMATION

VDE	CSA	UL
Certified according to IEC 60747-5-2	Approved under CSA Component Acceptance Notice: CA-5A	Recognized under 1577 Component Recognition Program ⁽¹⁾
File Number: 40016131	File Number: 1698195	File Number: E181974

(1) Production tested \geq 3000 V_{RMS} for 1 second in accordance with UL 1577.



<u>₩豐簡980721-Q1"供应商</u>

SLLS918-JULY 2008

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

V_{CC}	Supply voltage ⁽²⁾ , V _{CC1} , V _{CC2}		–0.5 V to 6 V
VI	Voltage at IN or OUT terminal	–0.5 V to 6 V	
I _O	Output current	±15 mA	
TJ	Maximum virtual-junction temperature		170°C
	Electronic de la chemica de la c	Human-Body Model ⁽³⁾	±2 kV
ESD	Electrostatic discharge rating	Charged-Device Model ⁽⁴⁾	±1 kV

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values except differential I/O bus voltages are with respect to network ground terminal and are peak voltage values. Vrms values are not listed in this publication.

(3) JEDEC Standard 22, Test Method A114-C.01

(4) JEDEC Standard 22, Test Method C101

RECOMMENDED OPERATING CONDITIONS

				MIN	MAX	UNIT
V _{CC}	Supply voltage ⁽¹⁾ , V _{CC1} , V _{CC2}	Supply voltage ⁽¹⁾ , V _{CC1} , V _{CC2}				V
I _{OH}	High-level output current	High-level output current			4	mA
I _{OL}	Low-level output current	Low-level output current				mA
t _{ui}	Input pulse width		10		ns	
V_{IH}	High-level input voltage (IN)			2	V_{CC}	V
V_{IL}	Low-level input voltage (IN)			0	0.8	V
T _A	Operating free-air temperature			-40	125	°C
T_{J}	Operating virtual-junction temperature See the Thermal Characteristics table			150	°C	
Н	External magnetic field intensity per IEC 61000-4-8 and IEC 61000-4-9 certification				1000	A/m

(1) For 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V. For 3.3-V operation, V_{CC1} or V_{CC2} is specified from 3 V to 3.6 V.

IEC 60747-5-2 INSULATION CHARACTERISTICS⁽¹⁾

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	SPECIFICATIONS	UNIT
VIORM	Maximum working insulation voltage		560	V
	Input to output test voltage	After Input/Output Safety Test Subgroup 2/3 $V_{PR} = V_{IORM} \times 1.2$, t = 10 s, Partial discharge < 5 pC	672	V
V _{PR}		Method a, $V_{PR} = V_{IORM} \times 1.6$, Type and sample test with t = 10 s, Partial discharge < 5 pC	896	V
		Method b1, $V_{PR} = V_{IORM} \times 1.875$, 100 % Production test with t = 1 s, Partial discharge < 5 pC	1050	V
VIOTM	Transient overvoltage	t = 60 s	4000	V
R _S	Insulation resistance	$V_{IO} = 500 \text{ V at } T_{S}$	>10 ⁹	Ω
	Pollution degree		2	

(1) Climatic Classification 40/125/21

TEXAS INSTRUMENTS

www.ti.com

SL誓销+悦的控释-Q1-供应商

ELECTRICAL CHARACTERISTICS: V_{cc1} and V_{cc2} 5-V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
	V _{CC1} supply current	Quiescent	V V at 0 V Na load		0.5	1	A
I _{CC1}		25 Mbps	$V_{I} = V_{CC}$ or 0 V, No load		2	4	mA
I _{CC2}		Quiescent	$\gamma = \gamma$ or 0γ . No load		8	12	mA
	V _{CC2} supply current 25 Mbps	25 Mbps	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ No load}$		10	14	IIIA
V _{OH}	High-level output voltage		I _{OH} = -4 mA, See Figure 1	$V_{CC} - 0.8$	4.6		v
∨он			$I_{OH} = -20 \ \mu A$, See Figure 1	V _{CC} - 0.1	5		v
V			I _{OL} = 4 mA, See Figure 1		0.2	0.4	v
V _{OL}	Low-level output voltage		I_{OL} = 20 µA, See Figure 1		0	0.1	v
V _{I(HYS)}	Input voltage hysteresis				150		mV
I _{IH}	High-level input current		IN at 2 V			10	۸
I _{IL}	Low-level input current		IN at 0.8 V	-10			μA
CI	Input capacitance to ground		IN at V_{CC} , $V_I = 0.4 \sin (4E6\pi t)$		1		pF
CMTI	Common-mode transient immunity		$V_1 = V_{CC}$ or 0 V, See Figure 3	15	50		kV/μs

(1) For 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V. For 3.3-V operation, V_{CC1} or V_{CC2} is specified from 3 V to 3.6 V.

SWITCHING CHARACTERISTICS: V_{CC1} and V_{CC2} 5-V OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH}	Propagation delay, low-to-high-level output	See Figure 1		17	24	ns
t _{PHL}	Propagation delay , high-to-low-level output	See Figure 1		17	24	ns
t _{sk(p)}	Pulse skew t _{PHL} – t _{PLH}	See Figure 1		0.5	2	ns
t _{sk(pp)} ⁽¹⁾	Part-to-part skew			0	3	ns
t _r	Output signal rise time	See Figure 1		1		ns
t _f	Output signal fall time	See Figure 1		1		ns
t _{fs}	Failsafe output delay time from input power loss	See Figure 2		3		μs
t _{jit(PP)}	Peak-to-peak eye-pattern jitter	100-Mbps NRZ data input, See Figure 4		2		
		100-Mbps unrestricted bit run length data input, See Figure 4		3		ns

(1) t_{sk(PP)} is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.



SLLS918-JULY 2008

ELECTRICAL CHARACTERISTICS: V_{CC1} at 5-V, V_{CC2} at 3.3-V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
	Vcc1 supply current	Quiescent	V V or OV No lood		0.5	1	~ ^
I _{CC1}		25 Mbps	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ No load}$		2	4	mA
	V oursely ourrest	Quiescent	V V or 0.V No lood		4	6.5	
I _{CC2}	V _{CC2} supply current	25 Mbps	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ No load}$		5	7.5	mA
V	High-level output voltage		I _{OH} = -4 mA, See Figure 1	$V_{CC} - 0.4$	3		v
V _{OH}			$I_{OH} = -20 \ \mu A$, See Figure 1	$V_{CC} - 0.1$	3.3		v
V	Level and extend on the sec		I _{OL} = 4 mA, See Figure 1		0.2	0.4	V
V _{OL}	Low-level output voltage		$I_{OL} = 20 \ \mu A$, See Figure 1		0	0.1	V
V _{I(HYS)}	Input voltage hysteresis				150		mV
I _{IH}	High-level input current		IN at 2 V			10	μA
IIL	Low-level input current		IN at 0.8 V	-10			μA
CI	Input capacitance to ground		IN at V_{CC} , $V_I = 0.4 \sin (4E6\pi t)$		1		pF
CMTI	Common-mode transient immunity		$V_{I} = V_{CC}$ or 0 V, See Figure 3	15	40		kV/μs

(1) For 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V. For 3.3-V operation, V_{CC1} or V_{CC2} is specified from 3 V to 3.6 V.

SWITCHING CHARACTERISTICS: V_{CC1} at 5-V, V_{CC2} at 3.3-V OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH}	Propagation delay, low-to-high-level output	See Figure 1		19	30	ns
t _{PHL}	Propagation delay , high-to-low-level output	See Figure 1		19	30	ns
t _{sk(p)}	Pulse skew t _{PHL} – t _{PLH}	See Figure 1		0.5	3	ns
t _{sk(pp)} ⁽¹⁾	Part-to-part skew			0	5	ns
t _r	Output signal rise time	See Figure 1		2		ns
t _f	Output signal fall time	See Figure 1		2		ns
t _{fs}	Failsafe output delay time from input power loss	See Figure 2		3		μs
t _{jit(PP)}	Peak-to-peak eye-pattern jitter	100-Mbps NRZ data input, See Figure 4		2		
		100-Mbps unrestricted bit run length data input, See Figure 4		3		ns

(1) t_{sk(PP)} is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.

Texas Instruments

www.ti.com

SI 查销 化 的 2 和 人 1 世 供 应 商

ELECTRICAL CHARACTERISTICS: V_{CC1} at 3.3-V, V_{CC2} at 5-V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
		Quiescent	V V or OV No lood		0.3	0.5	
I _{CC1}	V _{CC1} supply current 25 Mbp	25 Mbps	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ No load}$		1	2	mA
	V oursely ourrest	Quiescent	V V or 0.V No lood		8	12	A
I _{CC2}	V _{CC2} supply current 25 Mbps	$V_{I} = V_{CC}$ or 0 V, No load		10	14	mA	
V	High-level output voltage		I _{OH} = -4 mA, See Figure 1	V _{CC} – 0.8	4.6		v
V _{OH}			$I_{OH} = -20 \ \mu A$, See Figure 1	V _{CC} – 0.1	5		v
V	Level and evaluation for the sec		I _{OL} = 4 mA, See Figure 1		0.2	0.4	v
V _{OL}	Low-level output voltage		$I_{OL} = 20 \ \mu A$, See Figure 1		0	0.1	v
V _{I(HYS)}	Input voltage hysteresis				150		mV
I _{IH}	High-level input current		IN at 2 V			10	μΑ
IIL	Low-level input current		IN at 0.8 V	-10			μΑ
CI	Input capacitance to ground		IN at V_{CC} , $V_I = 0.4 \sin (4E6\pi t)$		1		pF
CMTI	Common-mode transient ir	nmunity	$V_{I} = V_{CC}$ or 0 V, See Figure 3	15	40		kV/μs

(1) For 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V. For 3.3-V operation, V_{CC1} or V_{CC2} is specified from 3 V to 3.6 V.

SWITCHING CHARACTERISTICS: V_{CC1} at 3.3-V, V_{CC2} at 5-V OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH}	Propagation delay, low-to-high-level output	See Figure 1		17	30	ns
t _{PHL}	Propagation delay, high-to-low-level output	See Figure 1		17	30	ns
t _{sk(p)}	Pulse skew t _{PHL} – t _{PLH}	See Figure 1		0.5	3	ns
t _{sk(pp)} ⁽¹⁾	Part-to-part skew			0	5	ns
t _r	Output signal rise time	See Figure 1		1		ns
t _f	Output signal fall time	See Figure 1		1		ns
t _{fs}	Failsafe output delay time from input power loss	See Figure 2		3		μs
t _{fs} tjit(PP)	Daalu ta maalu awa mattana iittan	100-Mbps NRZ data input, See Figure 4		2		
	Peak-to-peak eye-pattern jitter	100-Mbps unrestricted bit run length data input, See Figure 4		3		ns

(1) t_{sk(PP)} is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.



SLLS918-JULY 2008

ELECTRICAL CHARACTERISTICS: V_{CC1} and V_{CC2} at 3.3-V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
		Quiescent			0.3	0.5	
I _{CC1}	V _{CC1} supply current 25 Mbps	25 Mbps	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ No load}$		1	2	mA
	V oursely ourrest	Quiescent			4	6.5	
I _{CC2}	V _{CC2} supply current 25 Mbps	$V_{I} = V_{CC} \text{ or } 0 \text{ V}, \text{ No load}$		5	7.5	mA	
V	/ _{OH} High-level output voltage		I _{OH} = -4 mA, See Figure 1	$V_{CC} - 0.4$	3		v
∨он			$I_{OH} = -20 \ \mu A$, See Figure 1	V _{CC} – 0.1	3.3		v
V			I _{OL} = 4 mA, See Figure 1		0.2	0.4	v
V _{OL}	Low-level output voltage		I_{OL} = 20 µA, See Figure 1		0	0.1	v
V _{I(HYS)}	Input voltage hysteresis				150		mV
I _{IH}	High-level input current		IN at 2 V			10	μA
IIL	Low-level input current		IN at 0.8 V	-10			μΑ
CI	Input capacitance to ground		IN at V_{CC} , $V_{I} = 0.4 \sin (4E6\pi t)$		1		pF
CMTI	Common-mode transient immunity		$V_{I} = V_{CC}$ or 0 V, See Figure 3	15	40		kV/μs

(1) For 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V. For 3.3-V operation, V_{CC1} or V_{CC2} is specified from 3 V to 3.6 V.

SWITCHING CHARACTERISTICS: V_{cc1} and V_{cc2} at 3.3-V OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH}	Propagation delay, low-to-high-level output	See Figure 1		20	34	ns
t _{PHL}	Propagation delay, high-to-low-level output	See Figure 1		20	34	ns
t _{sk(p)}	Pulse skew t _{PHL} – t _{PLH}	See Figure 1		0.5	3	ns
t _{sk(pp)} ⁽¹⁾	Part-to-part skew			0	5	ns
t _r	Output signal rise time	See Figure 1		2		ns
t _f	Output signal fall time	See Figure 1		2		ns
t _{fs}	Failsafe output delay time from input power loss	See Figure 2		3		μs
t _{jit(PP)}	Peak-to-peak eye-pattern jitter	100-Mbps NRZ data input, See Figure 4		2		
		100-Mbps unrestricted bit run length data input, See Figure 4		3		ns

(1) t_{sk(PP)} is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.

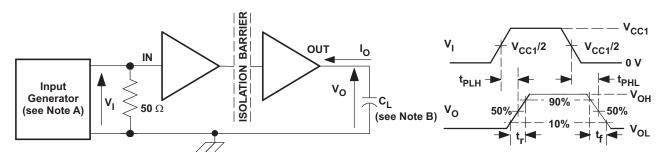
IS0721-Q1

TEXAS INSTRUMENTS

www.ti.com

SL整个部件的资料-Q1"供应商

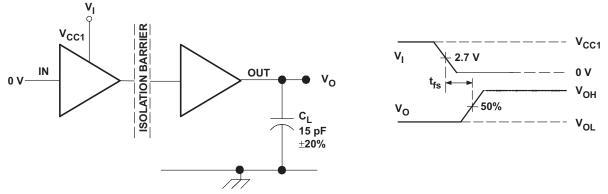
PARAMETER MEASUREMENT INFORMATION



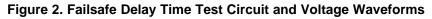
A. The input pulse is supplied by a generator having the following characteristics: PRR ≤ 50 kHz, 50% duty cycle, $t_r ≤ 3$ ns, $t_f ≤ 3$ ns, $Z_O = 50 \Omega$.

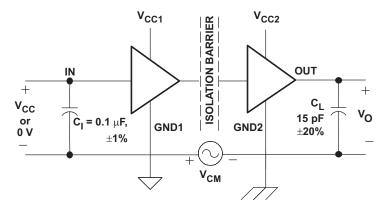
B. $C_L = 15 \text{ pF}$ and includes instrumentation and fixture capacitance within ±20%.

Figure 1. Switching Characteristic Test Circuit and Voltage Waveforms



NOTE: V_I transition time is 100 ns





NOTE: Pass/fail criteria is no change in V_O .

Figure 3. Common-Mode Transient Immunity Test Circuit and Voltage Waveform



Tektronix HFS9009 PATTERN GENERATOR U In put U U U U V CC1 0 V CC2/2 V CC2/2

PARAMETER MEASUREMENT INFORMATION (continued)

NOTE: Bit pattern run length is $2^{16} - 1$. Transition Time is 800 ps. NRZ data input has no more than five consecutive 1s or 0s.

Figure 4. Peak-to-Peak Eye-Pattern Jitter Test Circuit and Voltage Waveform

TEXAS INSTRUMENTS

 www.ti.com

DEVICE INFORMATION

PACKAGE CHARACTERISTICS

PARAMETER		TEST CONDITIONS		TYP	MAX	UNIT
L(101)	Minimum air gap (clearance) ⁽¹⁾	Shortest terminal-to-terminal distance through air	4.8			mm
L(102)	Minimum external tracking (creepage)	Shortest terminal to terminal distance across the package surface	4.3			mm
C _{TI}	Tracking resistance (comparative tracking index)	DIN IEC 60112/VDE 0303 Part 1	≥ 175			V
	Minimum internal gap (internal clearance)	Distance through insulation	0.008			mm
R _{IO}	Isolation resistance	Input to output, V_{IO} = 500 V, all pins on each side of the barrier tied together creating a two-terminal device, T_A < 100°C		>10 ¹²		Ω
		Input to output, $V_{IO} = 500 \text{ V}$, 100°C $\leq T_A < T_A \text{ max}$.		>10 ¹¹		Ω
C _{IO}	Barrier capacitance, input to output	V _I = 0.4 sin (4E6πt)		1		pF
Cl	Input capacitance to ground	V _I = 0.4 sin (4E6πt)		1		pF

(1) Creepage and clearance requirements are applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed circuit board do not reduce this distance.

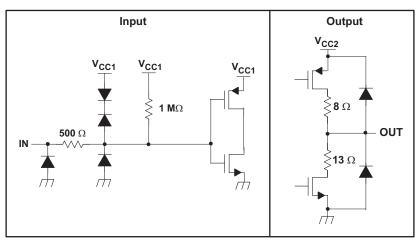
Creepage and clearance on a printed circuit board become equal according to the measurement techniques shown in the Isolation Glossary. Techniques such as inserting grooves and/or ribs on a printed circuit board are used to help increase these specifications.

IEC 60664-1 RATINGS TABLE

PARAMETER	TEST CONDITIONS	SPECIFICATION
Basic isolation group	Material group	Illa
Installation classification	Rated mains voltage ≤150 VRMS	I-IV
	Rated mains voltage ≤300 VRMS	1-111

DEVICE I/O SCHEMATIC

Equivalent Input and Output Schematic Diagrams





IEC SAFETY LIMITING VALUES

Safety limiting is designed to prevent potential damage to the isolation barrier upon failure of input or output circuitry. A failure of the IO can allow low resistance to ground or the supply, and without current limiting, dissipate sufficient power to overheat the die and damage the isolation barrier, potentially leading to secondary system failures.

	PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
	Sofety input output, or supply surrent	$\theta_{JA} = 263^{\circ}C/W, V_I = 5.5 V, T_J = 170^{\circ}C, T_A = 25^{\circ}C$		100	~
IS	Safety input, output, or supply current	$\theta_{JA} = 263^{\circ}C/W, V_I = 3.6 V, T_J = 170^{\circ}C, T_A = 25^{\circ}C$		153	mA
Τ _S	Maximum case temperature			150	°C

The safety-limiting constraint is the absolute maximum junction temperature specified in the absolute maximum ratings table. The power dissipation and junction-to-air thermal impedance of the device installed in the application hardware determines the junction temperature. The junction-to-air thermal resistance in the Thermal Characteristics table is that of a device installed in the JESD51-3, Low Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages and is conservative. The power is the recommended maximum input voltage times the current. The junction temperature is then the ambient temperature plus the power times the junction-to-air thermal resistance.

THERMAL CHARACTERISTICS (over recommended operating conditions unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
0	Junction-to-air thermal resistance	Low-K ⁽¹⁾		263		°C/W
θ_{JA} .		High-K ⁽¹⁾		125		C/vv
θ_{JB}	Junction-to-board thermal resistance			44		°C/W
θ_{JC}	Junction-to-case thermal resistance			75		°C/W
P _D	Device power dissipation	$V_{CC1} = V_{CC2} = 5.5 \text{ V}, \text{ T}_{J} = 150^{\circ}\text{C}, \text{ C}_{L} = 15 \text{ pF},$ Input a 100-Mbps 50% duty cycle square wave			159	mW

(1) Tested in accordance with the Low-K or High-K thermal metric definition of EIA/JESD51-3 for leaded surface-mount packages.

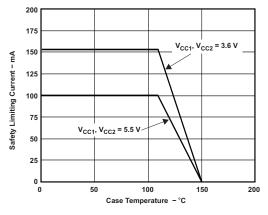


Figure 5. θ_{JC} Thermal Derating Curve Per IEC 60747-5-2

V _{CC1}	V _{CC2}	INPUT (IN)	OUTPUT (OUT)				
		Н	Н				
PU	PU	L	L				
		Open	Н				
PD	PU	Х	Н				

FUNCTION TABLE⁽¹⁾

(1) PU = powered up (V_{CC} \ge 3 V), PD = powered down (V_{CC} \le 2.5 V), X = irrelevant, H = high level, L = low level

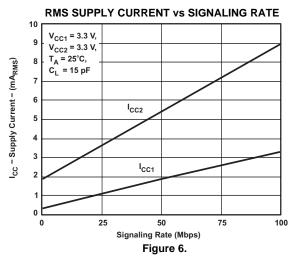


IS0721-Q1

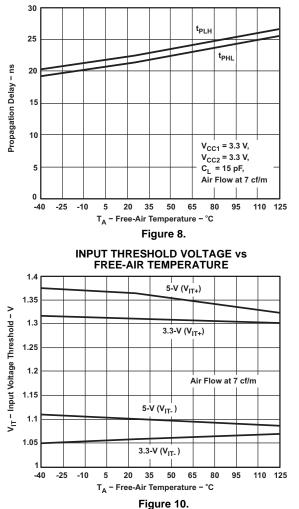
SLLS918-JULY 2008

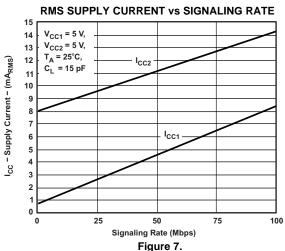
<u>₩豐簡♥ (60721-Q1"供应商</u>

TYPICAL CHARACTERISTICS

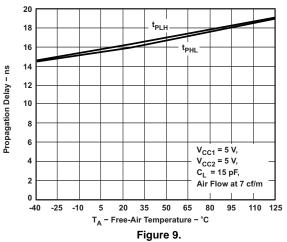


PROPAGATION DELAY vs FREE-AIR TEMPERATURE

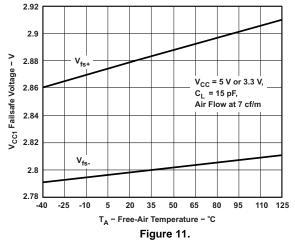




PROPAGATION DELAY vs FREE-AIR TEMPERATURE



V_{CC1} FAILSAFE THRESHOLD VOLTAGE vs FREE-AIR TEMPERATURE



IS0721-Q1

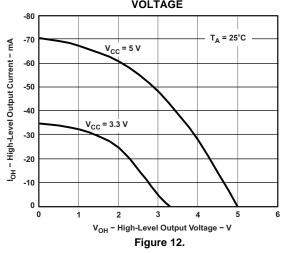


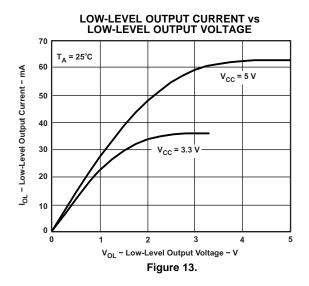
www.ti.com

SI 查销 化OPP Q1 供应商

TYPICAL CHARACTERISTICS (continued)









APPLICATION INFORMATION

MANUFACTURER CROSS-REFERENCE DATA

The ISO721 isolator has the same functional pinout as most other vendors, and it is often a pin-for-pin drop-in replacement. The notable differences in the product are propagation delay, signaling rate, power consumption, and transient protection rating. Table 1 is used as a guide for replacing other isolators with the ISO721 single-channel isolators.

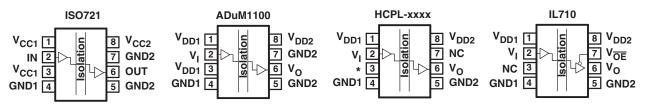


Figure 14. Pinout Cross Reference

Table 1. 0	Competitive	Cross	Reference
------------	-------------	-------	-----------

ISOLATOR	PIN 1	PIN 2	PIN 3	PIN 4	PIN 5	PIN 6	PIN 7	PIN 8
ISO721 ⁽¹⁾⁽²⁾	V _{CC1}	IN	V _{CC1}	GND1	GND2	OUT	GND2	V _{CC2}
ADuM1100 ⁽¹⁾⁽²⁾	V _{DD1}	VI	V _{DD1}	GND1	GND2	Vo	GND2	V _{DD2}
HCPL-xxxx	V _{DD1}	VI	Leave Open ⁽³⁾	GND1	GND2	Vo	NC	V _{DD2}
IL710	V _{DD1}	VI	NC ⁽⁴⁾	GND1	GND2	Vo	VOE	V _{DD2}

(1) The ISO721 pin 1 and pin 3 are internally connected together. Either or both may be used as V_{CC1} .

(2) The ISO721 pin 5 and pin 7 are internally connected together. Either or both may be used as GND2.

(3) Pin 3 of the HCPL devices must be left open. This is not a problem when substituting an ISO721, because the extra V_{CC1} on pin 3 may be left open circuit as well.

(4) Pin 3 of the IL710 must not be tied to ground on the circuit board, because this shorts the ISO721 V_{CC1} to ground. The IL710 pin 3 may only be tied to V_{CC} or left open to drop in an ISO721.

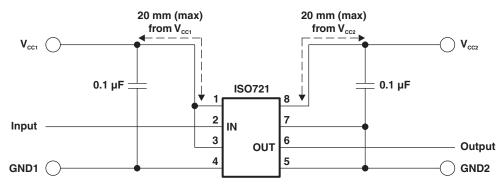


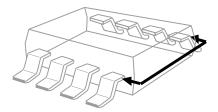
Figure 15. Basic Application Circuit

su響: 18:0329-Q1"供应商

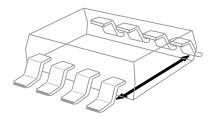


ISOLATION GLOSSARY

Creepage Distance — The shortest path between two conductive input to output leads measured along the surface of the insulation. The shortest distance path is found around the end of the package body.



Clearance — The shortest distance between two conductive input to output leads measured through air (line of sight).



Input-to-Output Barrier Capacitance — The total capacitance between all input terminals connected together, and all output terminals connected together.

Input-to-Output Barrier Resistance — The total resistance between all input terminals connected together, and all output terminals connected together.

Primary Circuit — An internal circuit directly connected to an external supply mains or other equivalent source which supplies the primary circuit electric power.

Secondary Circuit — A circuit with no direct connection to primary power, and derives its power from a separate isolated source.

Comparative Tracking Index (CTI) — CTI is an index used for electrical insulating materials and is defined as the numerical value of the voltage that causes failure by tracking during standard testing. Tracking is the process that produces a partially conducting path of localized deterioration on or through the surface of an insulating material as a result of the action of electric discharges on or close to an insulation surface -- the higher CTI value of the insulating material, the smaller the minimum creepage distance.

Generally, insulation breakdown occurs either through the material, over its surface, or both. Surface failure may arise from flashover or from the progressive degradation of the insulation surface by small localized sparks. Such sparks are the result of the breaking of a surface film of conducting contaminant on the insulation. The resulting break in the leakage current produces an overvoltage at the site of the discontinuity, and an electric spark is generated. These sparks often cause carbonization on insulation material and lead to a carbon track between points of different potential. This process is known as *tracking*.



Insulation

Operational insulation — Insulation needed for the correct operation of the equipment

Basic insulation — Insulation to provide basic protection against electric shock

Supplementary insulation — Independent insulation applied in addition to basic insulation in order to ensure protection against electric shock in the event of a failure of the basic insulation

Double insulation — Insulation comprising both basic and supplementary insulation

Reinforced insulation — A single insulation system that provides a degree of protection against electric shock equivalent to double insulation

Pollution Degree

Pollution Degree 1 — No pollution, or only dry, nonconductive pollution occurs. The pollution has no influence.

Pollution Degree 2 — Normally, only nonconductive pollution occurs. However, a temporary conductivity caused by condensation must be expected.

Pollution Degree 3 — Conductive pollution occurs or dry nonconductive pollution occurs that becomes conductive due to condensation, which is to be expected.

Pollution Degree 4 – Continuous conductivity occurs due to conductive dust, rain, or other wet conditions.

Installation Category

Overvoltage Category — This section addresses insulation coordination by identifying the transient overvoltages that may occur and by assigning four different levels as indicated in IEC 60664.

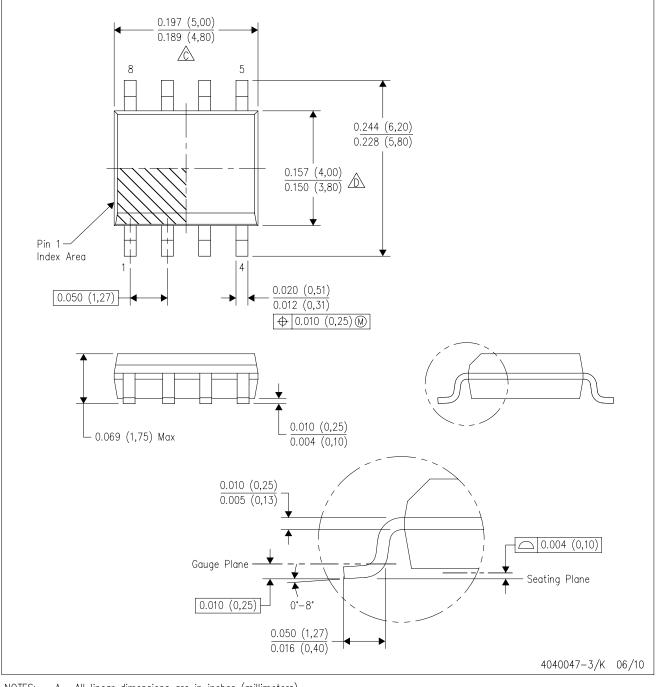
- I: Signal Level Special equipment or parts of equipment
- II: Local Level Portable equipment, etc.
- III: Distribution Level Fixed installation
- IV: Primary Supply Level Overhead lines, cable systems

Each category should be subject to smaller transients than the category above.

查询"ISO721-Q1"供应商

D (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
- Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
- E. Reference JEDEC MS-012 variation AA.



查询"ISO721-Q1"供应商

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DLP® Products	www.dlp.com	Communications and Telecom	www.ti.com/communications
DSP	dsp.ti.com	Computers and Peripherals	www.ti.com/computers
Clocks and Timers	www.ti.com/clocks	Consumer Electronics	www.ti.com/consumer-apps
Interface	interface.ti.com	Energy	www.ti.com/energy
Logic	logic.ti.com	Industrial	www.ti.com/industrial
Power Mgmt	power.ti.com	Medical	www.ti.com/medical
Microcontrollers	microcontroller.ti.com	Security	www.ti.com/security
RFID	www.ti-rfid.com	Space, Avionics & Defense	www.ti.com/space-avionics-defense
RF/IF and ZigBee® Solutions	www.ti.com/lprf	Video and Imaging	www.ti.com/video
		Wireless	www.ti.com/wireless-apps

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2010, Texas Instruments Incorporated